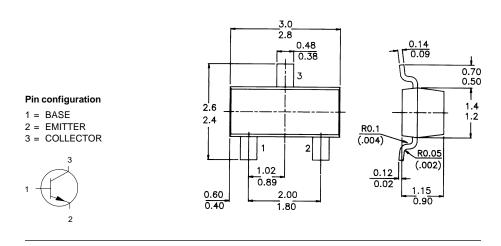


SOT-23 Formed SMD Package

SILICON N-P-N HIGH-VOLTAGE TRANSISTOR

N-P-N transistor

Marking CMBT5550 = 1F PACKAGE OUTLINE DETAILS ALL DIMENSIONS IN mm



ABSOLUTE MAXIMUM RATINGS

Collector-base voltage (open emitter)	V _{CBO}	max.	160	V
Collector-emitter voltage (open base)	V_{CEO}	max.	140	V
Collector current	I_C	max.	600	mА
Total power dissipation up to $T_{amb} = 25^{\circ}C$	P _{tot}	max	250	mW
Collector-emitter saturation voltage				
$I_C = 50 mA; I_B = 5 mA$	V _{CEsat}	max.	0.25	V
D.C. current gain				
$I_C = 10 mA; V_{CE} = 5 V$	h_{FE}	60 to 250		

RATINGS (at $T_A = 25^{\circ}C$ unless otherwise specified)

Limiting values				
Collector-base voltage (open emitter)	V_{CBO}	max.	160	V
Collector-emitter voltage (open base)	V_{CEO}	max.	140	V
Emitter-base voltage (open collector)	V_{EBO}	max.	6	V
Collector current	I_C	max.	600	mА

CMBT5550

Total power dissipation up to $T_{amb} = 25^{\circ}C$	P _{tot}	max		mW
Storage temperature	T _{stg}	-55 to		
Junction temperature	T_j	max.	150	° C
THERMAL RESISTANCE				
	D		500	K/W
from junction to ambient	R _{th j-a}		500	N/W
CHARACTERISTICS (at $T_A = 25^{\circ}C$ unless otherwise	specified)			
Collector cut-off current	•			
$I_E = 0; V_{CB} = 100 V$	I _{CBO}	max.	100	nA
$I_E = 0; V_{CB} = 100 V; T_{amb} = 100 °C$	I _{CBO}	max.	100	$\mathfrak{m}A$
Emitter cut-off current				
$I_C = 0; V_{EB} = 4.0 V$	I _{EBO}	max.	50	nA
Breakdown voltages				
$I_C = 1 mA; I_B = 0$	$V_{(BR)CEO}$	min.	140	V
$I_C = 10 \ \mu A; I_E = 0$	V _(BR) CBO	min.	160	V
$I_C = 0; I_E = 10 \ \mu A$	V _{(BR)EBO}	min.	6	V
Saturation voltages	T /		0.15	T 7
$I_{C} = 10 \ mA; I_{B} = 1 \ mA$	VCEsat	max.	0.15	V
	VBEsat	max.	1	V
$I_C = 50 mA; I_B = 5 mA$	VCEsat	max.	0.25	V
	VBEsat	max.	1.2	V
D.C. current gain				
$I_C = 1 mA; V_{CE} = 5 V$	hfe	min.	60	
$I_C = 10 \text{ mA}; V_{CE} = 5 V$	h _{FE}	min.	60	
		max.	250	
$I_C = 50 mA; V_{CE} = 5 V$	h _{FE}	min.	20	
Output capacitance at $f = 1$ MHz	"FL		20	
$I_E = 0; V_{CB} = 10 V$	C_{o}	max.	6	рF
Input capacitance at $f = 1$ MHz	00	max.	U	<i>P</i> ¹
$I_C = 0; V_{FB} = 10 V$	C_i	max.	30	pF
Transition frequency at $f = 100$ MHz	-1		00	r-
$I_C = 10 \text{ mA}; V_{CE} = 10 \text{ V}; T_{amb} = 25 \text{ °C}$	fT	min.	100	MHz
1C = 10 mm, vCE = 10 v, 1 amb = 23 C	11	max.	300	MHz

Customer Notes

Disclaimer

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Data Sheet